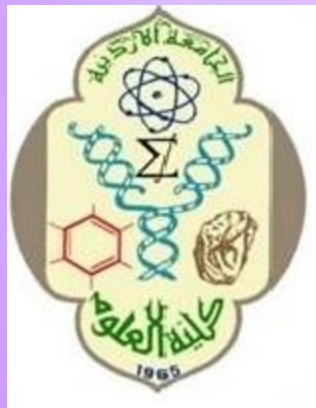


# *PIXE-RBS Beamline in the University of Jordan Van de Graaff Accelerator: Development and Applications*

*Hanan Sa'adeh*

*Rami Ali*

*Dia-Eddin Arafah*



*The University of Jordan  
Department of Physics  
Atomic Physics Lab*



# *Outline*

- *JUVAC*
- *RBS & PIXE techniques*
- *PIXE-RBS Beamline*
- *Results and Discussion*
- *Development & Applications*
- *Summary & Future Prospects*

# *Outline*

➤ *JUVAC*

➤ *RBS & PIXE techniques*

➤ *PIXE-RBS Beamline*

~~➤ *Results and Discussion*~~

➤ *Development & Applications*

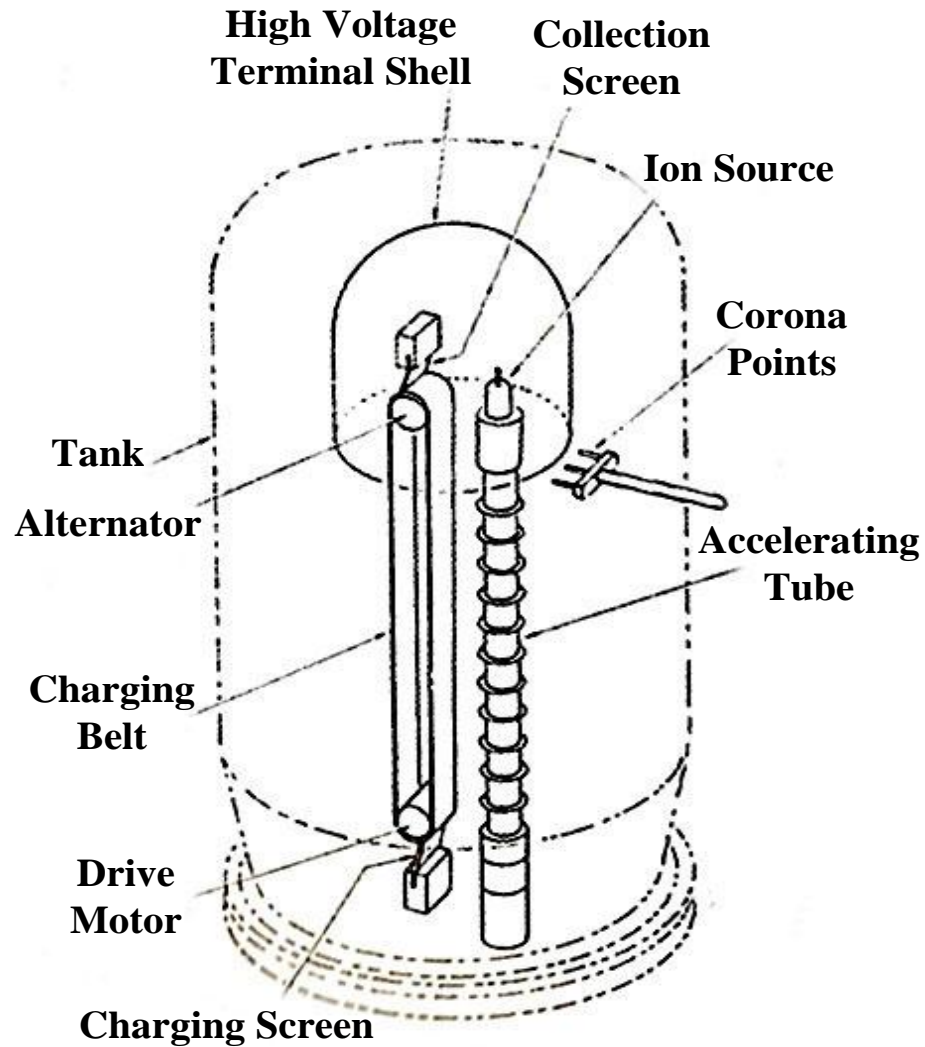
➤ *Summary & Future Prospects*

*The University of Jordan*  
*Van de Graaff Accelerator*  
**(JUVAC)**

# *JUVAC*

- *Electrostatic Linear Accelerator*
- *German Grant, GTZ, 1980s.*
- *Energy 0.3-4.75 MeV*
- *Ions ( $H^+$ ,  $He^{2+}$ ,  $O^+$ ,  $N^+$  ...)*
- *3 Operational Beamlines*  
*(RBS, COLTRIMS, PIXE-RBS)*

# Van de Graaff Accelerator



Chu, *et al.*, 1978





**JUVAC  
Experimental  
Hall**



# *JUVAC Staff*



*Salem Kharabshah*



*Huthifa Abdullah*



*Samir Farash*

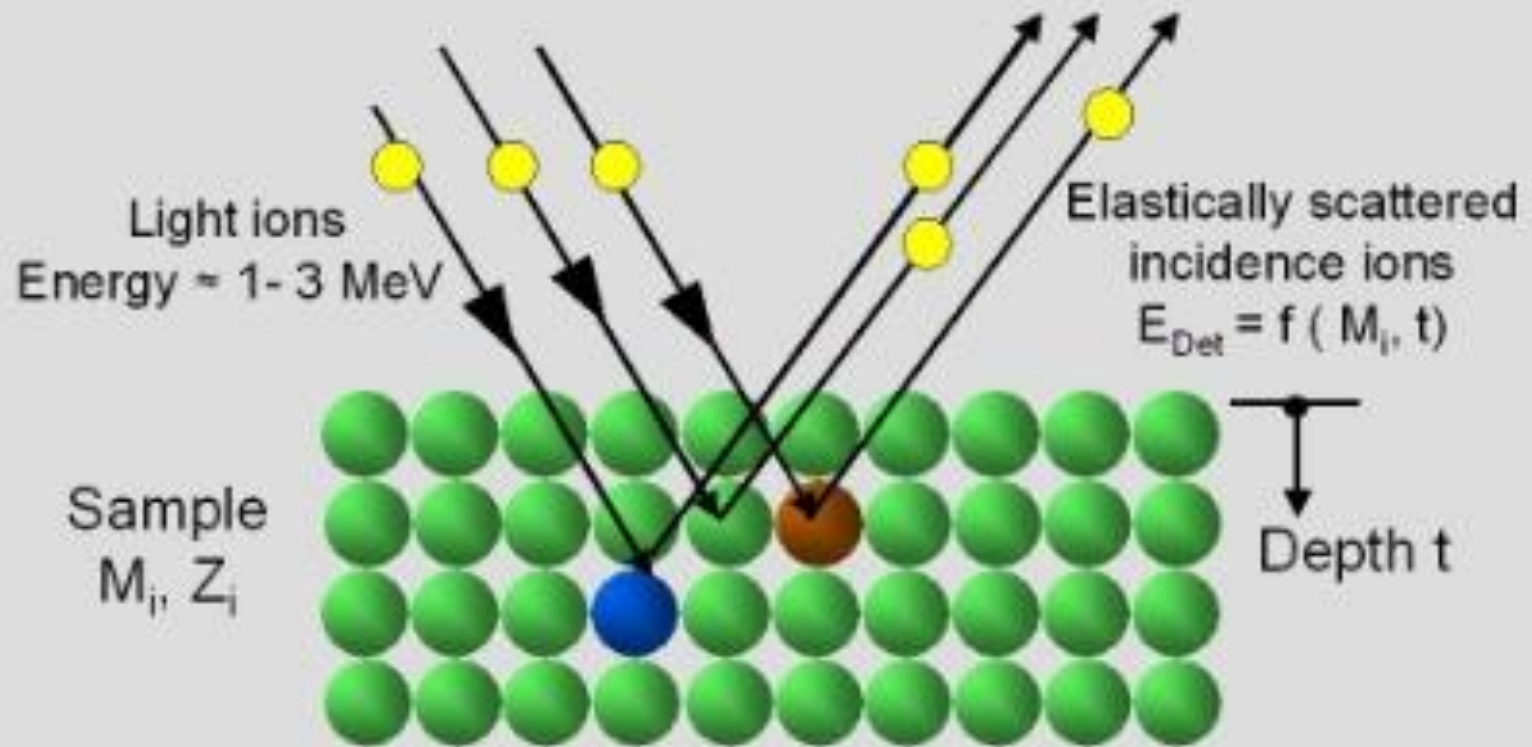




# *RBS & PIXE Techniques*

# RBS

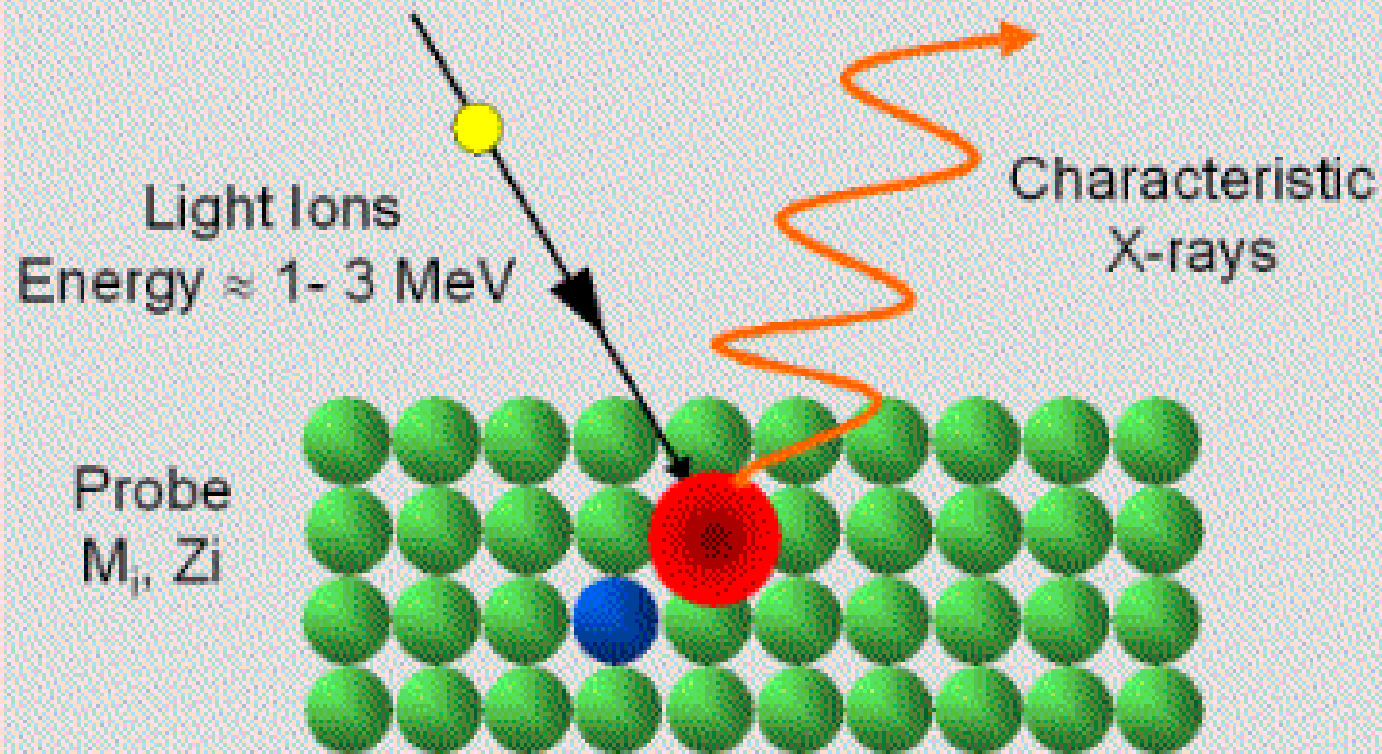
Rutherford backscattering spectrometry



Source: <http://www.hzdr.de>

# PIXE

Particle induced x-ray emission



Source: <http://www.hzdr.de>

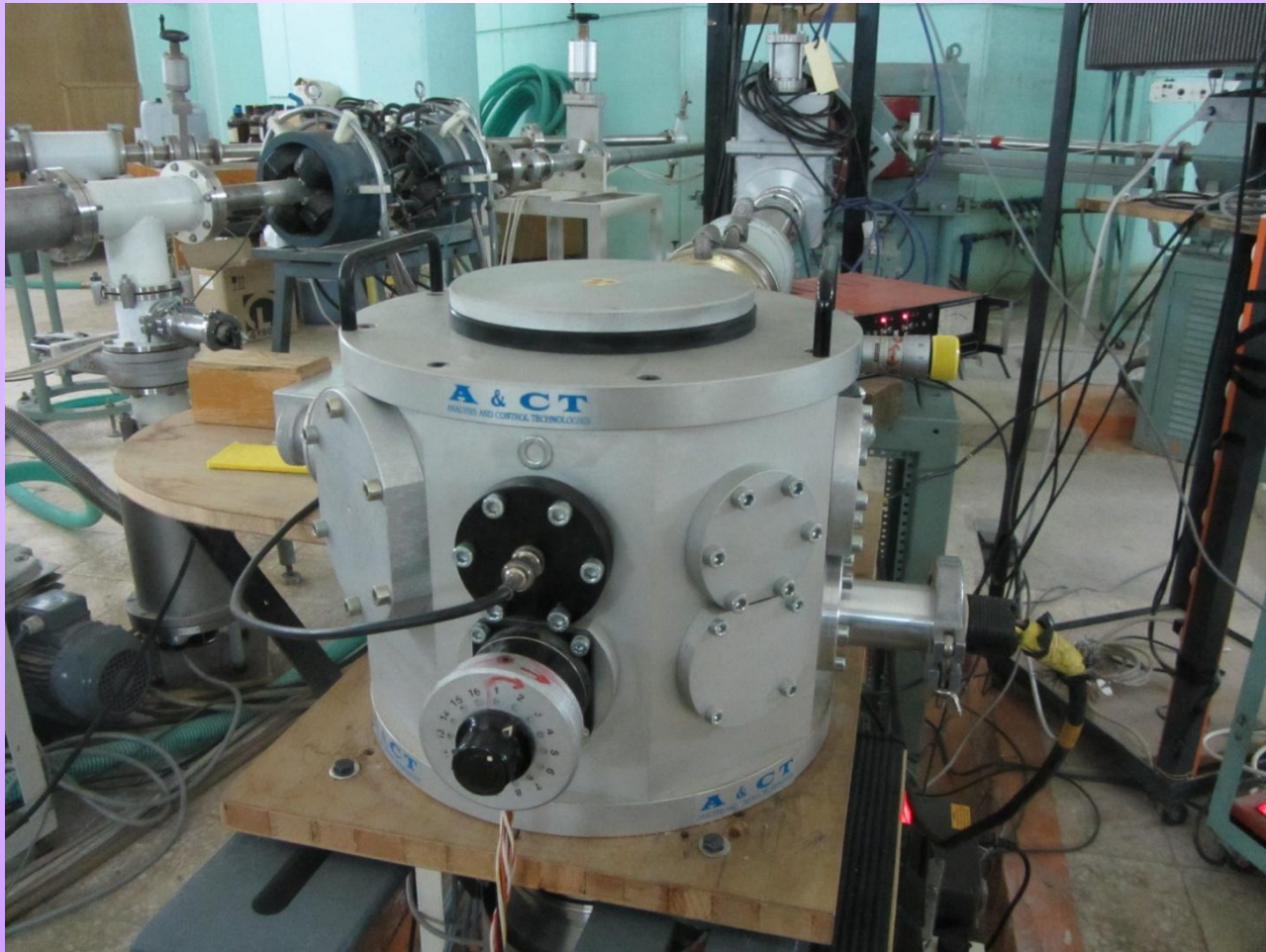
# *PIXE-RBS Beamline*

# Motivation

- *PIXE* can be used to detect elements (Na-U), *RBS* to detect all elements heavier than the projectile ions.
- *PIXE* is sensitive at the ppm level for most elements. *RBS* is suitable for profiling.
- The necessity of a powerful analytical technique to characterize the elemental content (*simultaneous identification & quantification*) of fine and coarse air particulates.



# *PIXE-RBS Beamline @ JUVAC*





# *Development & Applications*

# *PIXE-RBS Beamline Development*

- *Modification of the collision chamber of PIXE beamline to combine **PIXE** & **RBS** simultaneously.*
- *Installation of **Si (Li) X-ray detector** and **Gupix** software package (funded by the **IAEA**).*
- *Improving **vacuum** in the collision chamber.*

# *PIXE-RBS Beamline Applications*

- *Material analysis (stoichiometry of thin layers).*
- *Environmental studies (analysis of aerosols accumulated on filters).*
- *.....*

# *Summary & Future Prospects*

# Summary

- *RBS & PIXE are non-destructive techniques to study materials.*
- *PIXE-RBS combination allows the determination of depth distribution and concentration from hydrogen to heavy elements.*
- *PIXE-RBS combination gives complementary information in aerosols analysis.*

# *Future Prospect*

- *Modification of the collision chamber of PIXE-RBS beamline to be used for gaseous targets.*



# *Acknowledgements*



# *Atomic Physics Group at JU*



*Rami Ali*



*Hanan Sa'adeh*



*Dia-Eddin Arafah*

# *Jordan*



# *Amman*





*Thank You*

*hanan.saadeh@ju.edu.jo*

*ilovephysicsverymuch@yahoo.com*